



## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hisashi Ohtani                          Art Unit : 2811  
Serial No. : 10/657,137                          Examiner : Unknown  
Filed : September 9, 2003  
Title : SEMICONDUCTOR INTEGRATED CIRCUIT AND FABRICATION METHOD  
THEREOF

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

**INFORMATION DISCLOSURE STATEMENT**

Applicant submits the references listed on the attached form PTO-1449. This statement is being filed before the receipt of a first Office action on the merits.

Submitted herewith is an English translation of the following foreign language references, or portions thereof:

Desig. ID	Source
AL	Japan 05-308128 – English Abstract: DIALOG(R) File 345: Inpadoc/Fam. & Legal Stat (2004); Accession No. 11484654 and family to U.S. Patent No. 5,497,021 (Desig. ID “AA”) and U.S. Patent No. 5,545,577 (Desig. ID “AB”)
AM	Korea 1995-0033582 – English Abstract: DIALOG(R) File 352: Derwent WPI (2004); Accession No. 010528655 and family to U.S. Patent No. 5,889,291 (Desig. ID “AC”), U.S. Patent No. 6,441,399 (Desig. ID “AD”), U.S. Patent No. 6,599,791 (Desig. ID “AE”) and U.S. Patent Application Publication No. 2002/0195634 A1 (Desig. ID “AF”)

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Attorney's Docket No.: 07977-152003 / US3353D1D1

Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: April 19, 2004

  
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Sheet 1 of 1

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-152003	Application No. 10/657,137
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant Hisashi Ohtani		
		Filing Date September 9, 2003	Group Art Unit 2811	

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,497,021	03/05/1996	Tada			12/07/1994
	AB	5,545,577	08/13/1996	Tada			11/24/1993
	AC	5,889,291	03/30/1999	Koyama et al.			07/31/1996
	AD	6,441,399 B1	08/27/2002	Koyama et al.			01/13/1999
	AE	6,599,791 B1	07/29/2003	Koyama et al.			01/13/1999
	AF	2002/0195634 A1	12/26/2002	Koyama et al.			07/26/2002
	AG						
	AH						
	AI						
	AJ						
	AK						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	05-308128	11/19/1993	JAPAN			ABS	
	AM	1995-0033582	12/26/1995	KOREA			ABS	
	AN							
	AO							
	AP							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature

Date Considered

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.